

FORM PTO-1449
(REV. 7-80)U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
12336/7:1APPLICATION NO.
10/092,343INFORMATION DISCLOSURE CITATION
(Uses several sheets if necessary)APPLICANTS: Koichi Mukasa, Makoto Sawamura,
Kazuhisa Sueoka, and Eiichi HirotaFILING DATE
March 5, 2002GROUP
2878 2881 -cmk

U.S. PATENT DOCUMENTS

| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | NAME | CLASS | SUBCLASS | FILING DATE IF APPROPRIATE |
|---------------------|----|--------------------|------|------|-------|----------|-------------------------------|
| | AA | | | | | | |
| | AB | | | | | | |
| | AC | | | | | | |
| | AD | | | | | | |
| | AE | | | | | | |
| | AF | | | | | | |
| | AG | | | | | | |
| | AH | | | | | | |
| | AI | | | | | | |
| | AJ | | | | | | |
| | AK | | | | | | |

FOREIGN PATENT DOCUMENTS

| EXAMINER INITIAL | | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUBCLASS | TRANSLATION | |
|---------------------|----|--------------------|----------|---------|-------|----------|------------------|----|
| | | | | | | | YES | NO |
| cmk | AL | 2001264230 A | 26.09.01 | Japan | G01N | 13/16 | abstract only | |
| | AM | | | | | | | |
| | AN | | | | | | | |
| | AO | | | | | | | |
| | AP | | | | | | | |

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.)

| | | |
|-----|----|---|
| cmk | AR | K. Sueoka and K. Mukasa, <i>Development of Spin-Dependent Scanning Tunneling Microscopy</i> , School of Engineering, Hokkaido University and CREST, JST, Vol. 24, No. 12, 2000. |
| | AS | |
| | AT | |

EXAMINER *Chris Kalwoda*DATE CONSIDERED *Dec 8, 2003*

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.